

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/041,640	YAMANAKA ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Susan S. Lee	2852	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,781,206	07-1998	Edge, Christopher J.	----/----
	B	US-5,946,537	08-1999	Nakayasu et al.	399/301
	C	US-5,510,885	04-1996	Mori et al.	347/116
	D	US-6,603,495	08-2003	Hayakawa, Masahiro	347/116
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 08262830 A	10-1996	Japan	TOYOFUKU, NOBUSHI	G03G 15/01
*	O	JP 11065208 A	03-1999	Japan	SATO et al.	G03G 15/01
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.